



ALPHA & OMEGA
SEMICONDUCTOR

AO4720

N-Channel Enhancement Mode Field Effect Transistor

SRFET™



General Description

SRFET™ The AO4720 uses advanced trench technology with a monolithically integrated Schottky diode to provide excellent $R_{DS(ON)}$ and low gate charge. This device is suitable for use as a low side FET in SMPS, load switching and general purpose applications.

Standard Product AO4720 is Pb-free (meets ROHS & Sony 259 specifications).

Features

V_{DS} (V) = 30V

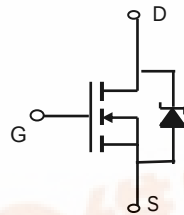
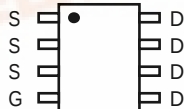
I_D = 13A (V_{GS} = 10V)

$R_{DS(ON)} < 11m\Omega$ (V_{GS} = 10V)

$R_{DS(ON)} < 17.5m\Omega$ (V_{GS} = 4.5V)

UIS TESTED!

$R_g, C_{iss}, C_{oss}, C_{rss}$ Tested



SRFET™

**Soft Recovery MOSFET:
Integrated Schottky Diode**

Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

Parameter	Symbol	Max		Units
		10 Sec	Steady State	
Drain-Source Voltage	V_{DS}	30		V
Gate-Source Voltage	V_{GS}	± 20		V
Continuous Drain Current ^{AF}	$T_A=25^\circ\text{C}$	13	10	A
		10.5	7.8	
Pulsed Drain Current ^B	I_{DM}	120		A
Avalanche Current ^C	I_{AR}	21		A
Repetitive avalanche energy $L=0.3mH$ ^C	E_{AR}	66		mJ
Power Dissipation	$T_A=25^\circ\text{C}$	3.1	1.7	W
		2.0	1.1	
Junction and Storage Temperature Range	T_J, T_{STG}	-55 to 150		$^\circ\text{C}$

Thermal Characteristics

Parameter		Symbol	Typ	Max	Units
Maximum Junction-to-Ambient ^A	$t \leq 10s$	$R_{\theta JA}$	32	40	$^\circ\text{C/W}$
Maximum Junction-to-Ambient ^A	Steady-State		60	75	$^\circ\text{C/W}$
Maximum Junction-to-Lead ^C	Steady-State	$R_{\theta JL}$	17	24	$^\circ\text{C/W}$

Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
STATIC PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =250μA, V _{GS} =0V	30			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =30V, V _{GS} =0V T _J =125°C			0.1 20	mA
I _{GSS}	Gate-Body leakage current	V _{DS} =0V, V _{GS} = ±20V			0.1	μA
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} I _D =250μA	1.3	1.62	2	V
I _{D(ON)}	On state drain current	V _{GS} =10V, V _{DS} =5V	120			A
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =13A T _J =125°C		9.3 13.8	11.0 17.3	mΩ
		V _{GS} =4.5V, I _D =11A		14	17.5	mΩ
g _{FS}	Forward Transconductance	V _{DS} =5V, I _D =13A		37		S
V _{SD}	Diode Forward Voltage	I _S =1A, V _{GS} =0V		0.40	0.5	V
I _S	Maximum Body-Diode + Schottky Continuous Current				5	A
DYNAMIC PARAMETERS						
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =15V, f=1MHz		1267	1600	pF
C _{oss}	Output Capacitance			308		pF
C _{rss}	Reverse Transfer Capacitance			118		pF
R _g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz		1.3	2.0	Ω
SWITCHING PARAMETERS						
Q _g (10V)	Total Gate Charge	V _{GS} =10V, V _{DS} =15V, I _D =13A		21	30	nC
Q _g (4.5V)	Total Gate Charge			10.4	14	nC
Q _{gs}	Gate Source Charge			3.0		nC
Q _{gd}	Gate Drain Charge			3.6		nC
t _{D(on)}	Turn-On DelayTime	V _{GS} =10V, V _{DS} =15V, R _L =1.2Ω, R _{GEN} =3Ω		5.2		ns
t _r	Turn-On Rise Time			3.8		ns
t _{D(off)}	Turn-Off DelayTime			21.2		ns
t _f	Turn-Off Fall Time			4.4		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =13A, dI/dt=300A/μs		11.2	17	ns
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =13A, dI/dt=300A/μs		10.5		nC

A: The value of R_{θJA} is measured with the device mounted on 1in 2 FR-4 board with 2oz. Copper, in a still air environment with T_A=25°C. The value in any given application depends on the user's specific board design.

B: Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=150°C.

C: The R_{θJA} is the sum of the thermal impedance from junction to lead R_{θJL} and lead to ambient.

D: The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

E: These tests are performed with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T_A=25°C. The SOA curve provides a single pulse rating.

F: The power dissipation and current rating is based on the t≤ 10s junction to ambient thermal resistance rating.

Rev1: May. 2007

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

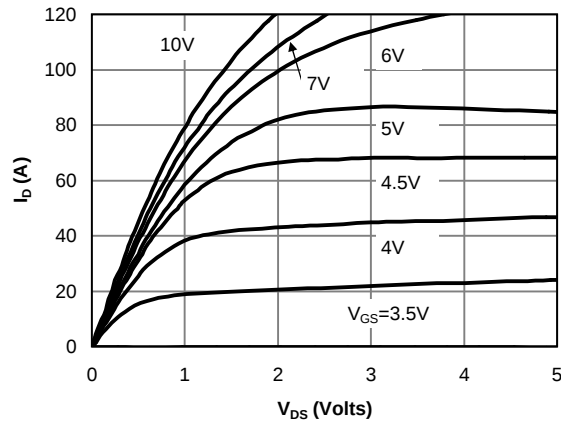


Figure 1: On-Region Characteristics

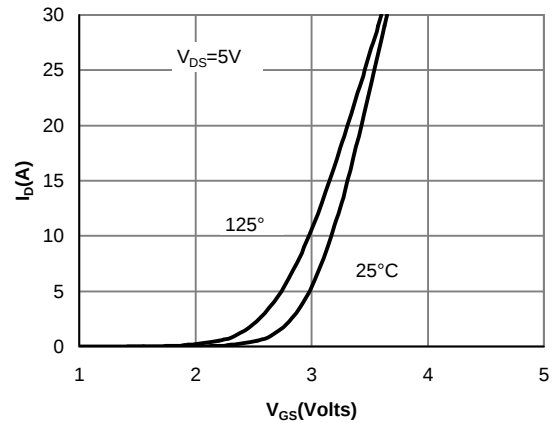


Figure 2: Transfer Characteristics

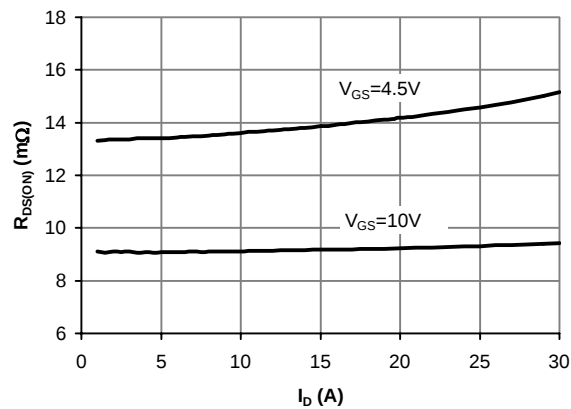


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

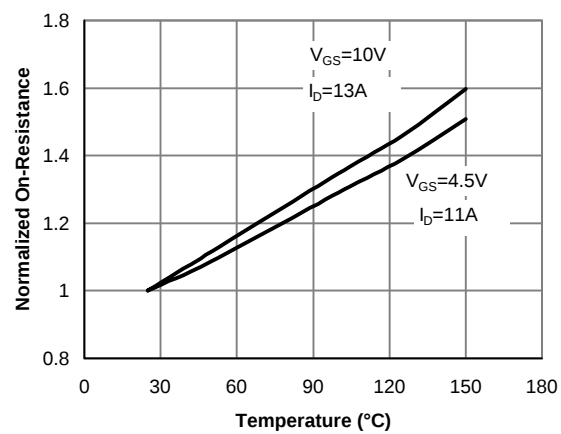


Figure 4: On-Resistance vs. Junction Temperature

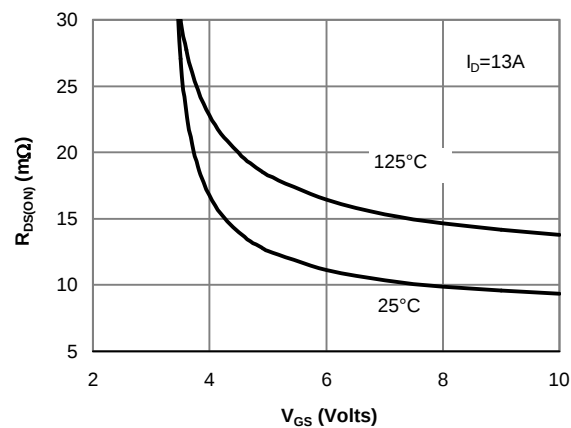


Figure 5: On-Resistance vs. Gate-Source Voltage

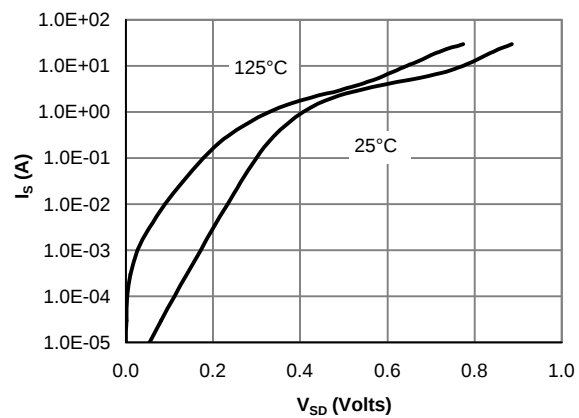


Figure 6: Body-Diode Characteristics

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